MOSFET - Power, Single, N-Channel, DPAK/IPAK 30 V, 117 A

Features

- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- AEC Q101 Qualified NVD4804N
- These Devices are Pb-Free and are RoHS Compliant

Applications

- CPU Power Delivery
- DC-DC Converters
- Low Side Switching

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Param	Parameter			Value	Unit
Drain-to-Source Voltag	je		V_{DSS}	30	V
Gate-to-Source Voltag	е		V_{GS}	±20	V
Continuous Drain		T _A = 25°C	I _D	19.6	Α
Current (R _{θJA}) (Note 1)		T _A = 85°C		15.2	
Power Dissipation ($R_{\theta JA}$) (Note 1)		T _A = 25°C	P _D	2.66	W
Continuous Drain		T _A = 25°C	I _D	14.5	Α
Current (R _{θJA}) (Note 2)	Steady	T _A = 85°C		11	
Power Dissipation ($R_{\theta JA}$) (Note 2)	State	T _A = 25°C	P _D	1.43	W
Continuous Drain		T _C = 25°C	I _D	124	Α
Current (R _{θJC}) (Note 1)		T _C = 85°C		96	
Power Dissipation ($R_{\theta JC}$) (Note 1)		T _C = 25°C	P _D	107	W
Pulsed Drain Current	t _p =10μs	T _A = 25°C	I _{DM}	230	Α
Current Limited by Pack	age	T _A = 25°C	I _{DmaxPkg}	45	Α
Operating Junction and	Operating Junction and Storage Temperature			-55 to 175	°C
Source Current (Body Diode)			I _S	78	Α
Drain to Source dV/dt		dV/dt	6.0	V/ns	
Single Pulse Drain-to-Source Avalanche Energy (V_{DD} = 24 V, V_{GS} = 10 V, L = 1.0 mH, $I_{L(pk)}$ = 30 A, R_{G} = 25 Ω)			E _{AS}	450	mJ
Lead Temperature for So (1/8" from case for 10 s)	Idering Pu	rposes	T _L	260	°C

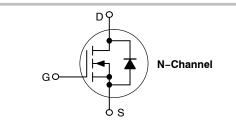
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.



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V _{(BR)DSS}	R _{DS(on)} MAX	I _D MAX
30 V	4.0 mΩ @ 10 V	117 A
30 V	5.5 mΩ @ 4.5 V	117.6







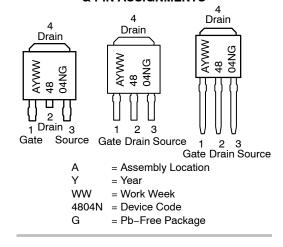


CASE 369AA DPAK (Bent Lead) STYLE 2

CASE 369AD 3 IPAK (Straight Lead)

CASE 369D IPAK (Straight Lead DPAK)

MARKING DIAGRAMS & PIN ASSIGNMENTS



ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 6 of this data sheet.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{ heta JC}$	1.4	°C/W
Junction-to-TAB (Drain)	$R_{ heta JC-TAB}$	3.5	
Junction-to-Ambient - Steady State (Note 1)	$R_{ heta JA}$	56.4	
Junction-to-Ambient - Steady State (Note 2)	$R_{ heta JA}$	105	

- Surface-mounted on FR4 board using 1 in sq pad size, 1 oz Cu.
 Surface-mounted on FR4 board using the minimum recommended pad size.

Parameter	Symbol	Test Cond	lition	Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D$	= 250 μΑ	30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J				26		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V,	T _J = 25°C			1.0	μΑ
		V _{DS} = 24 V	T _J = 125°C			10	
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS}$	= ±20 V			± 100	nA
ON CHARACTERISTICS (Note 3)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_{D}$	= 250 μΑ	1.5		2.5	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				7.6		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 to 11.5 V	I _D = 30 A		3.4	4.0	mΩ
			I _D = 15 A		3.4		
		V _{GS} = 4.5 V	I _D = 30 A		4.7	5.5	
			I _D = 15 A		4.6		
Forward Transconductance	gFS	V _{DS} = 15 V, I _I	₀ = 15 A		23		S
CHARGES AND CAPACITANCES							
Input Capacitance	C _{iss}				4490		pF
Output Capacitance	C _{oss}	V _{GS} = 0 V, f = V _{DS} = 1			952		
Reverse Transfer Capacitance	C _{rss}	VDS - 12 V			556		
Total Gate Charge	Q _{G(TOT)}				30	40	nC
Threshold Gate Charge	Q _{G(TH)}	V _{GS} = 4.5 V, V _I	_{OS} = 15 V,		5.5		
Gate-to-Source Charge	Q_{GS}	I _D = 30	Α		13		
Gate-to-Drain Charge	Q_{GD}				13		
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 11.5 V, V I _D = 30			73		nC
SWITCHING CHARACTERISTICS (Note	= 4)				•	•	-
Turn-On Delay Time	t _{d(on)}				18		ns
Rise Time	t _r	V _{GS} = 4.5 V, V _{DS} = 15 V,			20		1
Turn-Off Delay Time	t _{d(off)}	I _D = 15 A, R _G	= 3.0 Ω		24		1
Fall Time	t _f				8		1
Turn-On Delay Time	t _{d(on)}				10		ns
Rise Time	t _r	V _{GS} = 11.5 V, V	_{DS} = 15 V,		19		1
Turn-Off Delay Time	t _{d(off)}	$I_D = 15 A, R_G$			35		1
	.	1	ŀ		t	1	1

3. Pulse Test: Pulse Width \leq 300 μ s, Duty Cycle \leq 2%.

Fall Time

4. Switching characteristics are independent of operating junction temperatures.

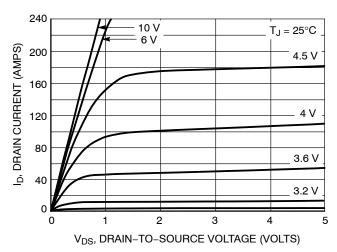
5

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted)

Parameter	Symbol	Test Co	ndition	Min	Тур	Max	Unit
DRAIN-SOURCE DIODE CHARACTI	ERISTICS	•					
Forward Diode Voltage	V _{SD}	V _{GS} = 0 V,	$T_J = 25^{\circ}C$		0.81	1.2	V
		I _S = 30 A	T _J = 125°C		0.72		1
Reverse Recovery Time	t _{RR}		•		34		ns
Charge Time	ta	V_{GS} = 0 V, dls/dt = 100 A/ μ s, I_S = 30 A			19		1
Discharge Time	tb				15		1
Reverse Recovery Time	Q_{RR}				30		nC
PACKAGE PARASITIC VALUES							
Source Inductance	L _S				2.49		nH
Drain Inductance, DPAK	L _D	1			0.0164		1
Drain Inductance, IPAK	L _D	$T_A = 1$	25°C		1.88		1
Gate Inductance	L _G	1			3.46		1
Gate Resistance	R_{G}	1			0.6		Ω

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

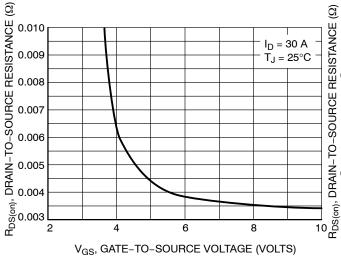
TYPICAL PERFORMANCE CURVES



240 $V_{DS} \geq 10 \ V$ $T_J = 125^{\circ}C$ $T_J = 25^{\circ}C$ ۵ 40 T_J = -55°C 0 2 5 6 7 0 3 V_{GS}, GATE-TO-SOURCE VOLTAGE (VOLTS)

Figure 1. On-Region Characteristics

Figure 2. Transfer Characteristics



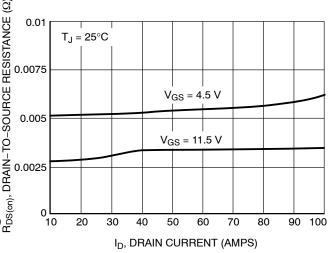
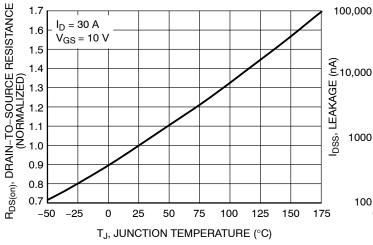


Figure 3. On-Resistance vs. Gate-to-Source Voltage

Figure 4. On-Resistance vs. Drain Current and Gate Voltage



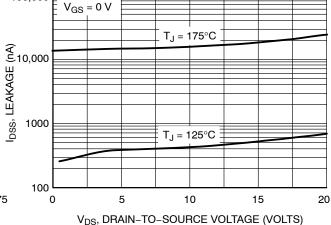
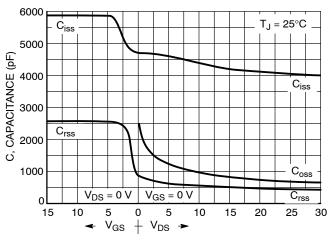


Figure 5. On–Resistance Variation with Temperature

Figure 6. Drain-to-Source Leakage Current vs. Drain Voltage

TYPICAL PERFORMANCE CURVES



GATE-TO-SOURCE OR DRAIN-TO-SOURCE VOLTAGE (VOLTS)

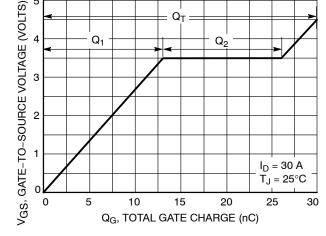


Figure 8. Gate-To-Source and Drain-To-Source Voltage vs. Total Charge



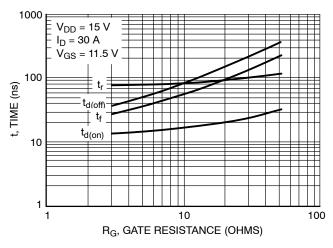


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

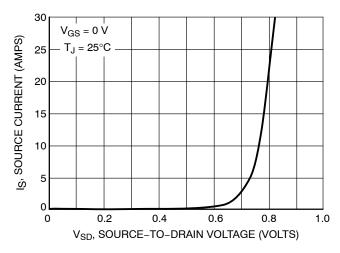


Figure 10. Diode Forward Voltage vs. Current

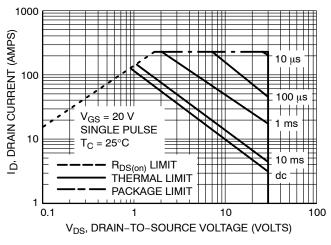


Figure 11. Maximum Rated Forward Biased Safe Operating Area

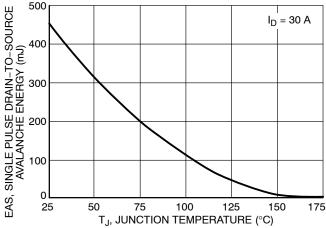


Figure 12. Maximum Avalanche Energy vs. Starting Junction Temperature

TYPICAL PERFORMANCE CURVES

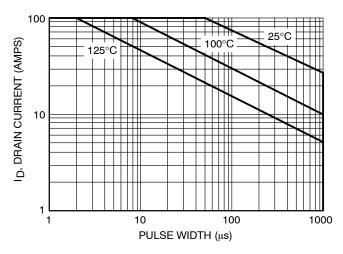


Figure 13. Avalanche Characteristics

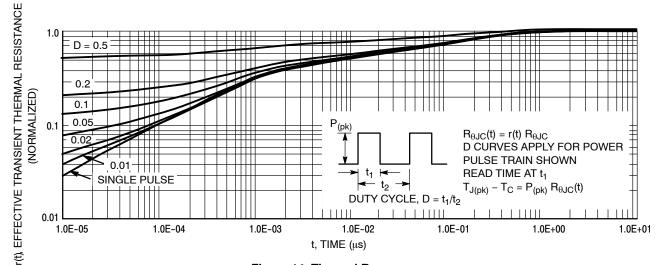


Figure 14. Thermal Response

ORDERING INFORMATION

Order Number	Package	Shipping [†]
NTD4804NT4G	DPAK (Pb-Free)	2500 / Tape & Reel
NTD4804N-35G	IPAK Trimmed Lead (3.5 ± 0.15 mm) (Pb-Free)	75 Units / Rail
NVD4804NT4G	DPAK (Pb-Free)	2500 / Tape & Reel
NVD4804NT4G-VF01	DPAK (Pb-Free)	2500 / Tape & Reel

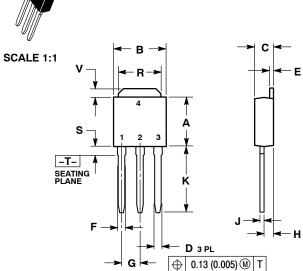
[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

MECHANICAL CASE OUTLINE





DATE 15 DEC 2010



STYLE 2:

PIN 1. GATE

3

STYLE 6: PIN 1. MT1 2. MT2 3. GATE

2. DRAIN

4. DRAIN

MT2

SOURCE

STYLE 1: PIN 1. BASE

3

STYLE 5: PIN 1. GATE

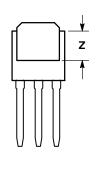
2. ANODE 3. CATHODE

ANODE

2. COLLECTOR

EMITTER

COLLECTOR



NOTES:

- DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
 2. CONTROLLING DIMENSION: INCH.

	INC	HES	MILLIN	METERS	
DIM	MIN	MAX	MIN	MAX	
Α	0.235	0.245	5.97	6.35	
В	0.250	0.265	6.35	6.73	
С	0.086	0.094	2.19	2.38	
D	0.027	0.035	0.69	0.88	
E	0.018	0.023	0.46	0.58	
F	0.037	0.045	0.94	1.14	
G	0.090	BSC	2.29 BSC		
Н	0.034	0.040	0.87	1.01	
J	0.018	0.023	0.46	0.58	
K	0.350	0.380	8.89	9.65	
R	0.180	0.215	4.45	5.45	
S	0.025	0.040	0.63	1.01	
٧	0.035	0.050	0.89	1.27	
Z	0.155		3.93		

MARKING DIAGRAMS

STYLE 3: PIN 1. ANODE

2. CATHODE

4. CATHODE

3 ANODE

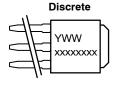
STYLE 7: PIN 1. GATE 2. COLLECTOR

3. EMITTER

COLLECTOR

STYLE 4: PIN 1. CATHODE ANODE
 GATE

4. ANODE

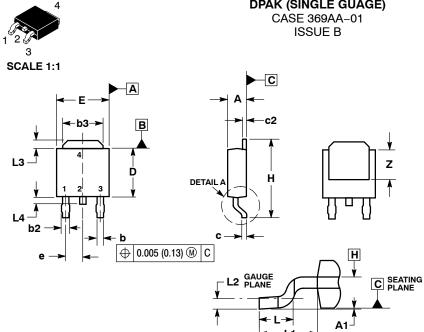




xxxxxxxxx = Device Code Α = Assembly Location IL = Wafer Lot Υ = Year WW = Work Week

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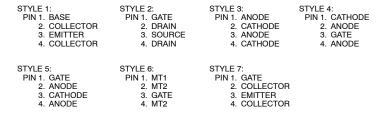


DETAIL A ROTATED 90° CW **DATE 03 JUN 2010**

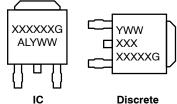
NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
- 2. CONTROLLING DIMENSION: INCHES.
 3. THERMAL PAD CONTOUR OPTIONAL WITHIN DI-MENSIONS b3, L3 and Z.
 4. DIMENSIONS D AND E DO NOT INCLUDE MOLD
- FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.006 INCHES PER SIDE
- DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
- 6. DATUMS A AND B ARE DETERMINED AT DATUM PLANE H.

	INC	HES	MILLIN	IETERS	
DIM	MIN	MAX	MIN	MAX	
Α	0.086	0.094	2.18	2.38	
A1	0.000	0.005	0.00	0.13	
b	0.025	0.035	0.63	0.89	
b2	0.030	0.045	0.76	1.14	
b3	0.180	0.215	4.57	5.46	
С	0.018	0.024	0.46	0.61	
c2	0.018	0.024	0.46	0.61	
D	0.235	0.245	5.97	6.22	
E	0.250	0.265	6.35	6.73	
е	0.090	BSC	2.29 BSC		
Н	0.370	0.410	9.40	10.41	
L	0.055	0.070	1.40	1.78	
L1	0.108 REF 0.020 BSC		2.74 REF		
L2			0.51	BSC	
L3	0.035	0.050	0.89	1.27	
L4		0.040		1.01	
Z	0.155		3.93		



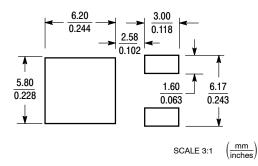
GENERIC MARKING DIAGRAM*



XXXXXX = Device Code Α = Assembly Location L = Wafer Lot ٧ = Year = Work Week WW = Pb-Free Package

*This information is generic. Please refer to device data sheet for actual part marking.

SOLDERING FOOTPRINT*



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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DESCRIPTION:	DPAK (SINGLE GAUGE)		PAGE 1 OF 1	

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MECHANICAL CASE OUTLINE

PACKAGE DIMENSIONS



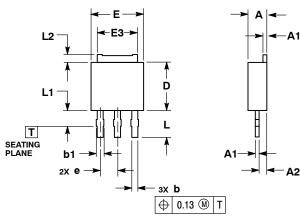


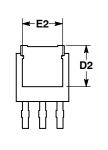
3.5 MM IPAK, STRAIGHT LEAD

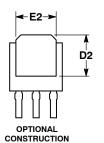
CASE 369AD **ISSUE B**

DATE 18 APR 2013









STYLE 4: PIN 1. CATHODE

3. GATE

2. ANODE

ANODE

- NOTES:
 1.. DIMENSIONING AND TOLERANCING PER
- ASME Y14.5M, 1994. 2.. CONTROLLING DIMENSION: MILLIMETERS.
- DIMENSION b APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.15 AND 0.30mm FROM TERMINAL TIP.
- DIMENSIONS D AND E DO NOT INCLUDE MOLD GATE OR MOLD FLASH.

	MILLIN	IETERS	
DIM	MIN	MAX	
Α	2.19	2.38	
A1	0.46	0.60	
A2	0.87	1.10	
b	0.69	0.89	
b1	0.77	1.10	
D	5.97	6.22	
D2	4.80		
E	6.35	6.73	
E2	4.57	5.45	
E3	4.45	5.46	
е	2.28 BSC		
L	3.40	3.60	
L1		2.10	
L2	0.89	1.27	

GENERIC MARKING DIAGRAMS*

Integrated

STYL	Ε	1	:	
PIN	1			RA

4. STYLE 5:

PIN 1. GATE

ASE 2. COLLECTOR 3. **EMITTER**

ANODE
 CATHODE

ANODE

COLLECTOR

STYLE 2: PIN 1. GATE

STYLE 6:

PIN 1. MT1

MT2
 GATE

MT2

2. DRAIN 3. SOURCE DRAIN

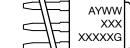
STYLE 3: PIN 1. ANODE 2. CATHODE

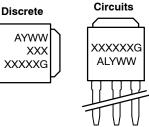
STYLE 7:

3. ANODE CATHODE

PIN 1. GATE 2. COLLECTOR 3. EMITTER

COLLECTOR





XXXXXX = Device Code

Α = Assembly Location

L = Wafer Lot Υ = Year WW = Work Week G = Pb-Free Package

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " ■", may or may not be present.

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DESCRIPTION	3.5 MM IPAK STRAIGHT LEAD		PAGE 1 OF 1

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